

Quartz crystals - professional applications HC-49/SMD-like

9922 522 43... series

FEATURES

- Outstanding electrical performance
- Low resistance values
- High pullability values
- High mechanical and electrical stability
- Low ageing.

APPLICATIONS

- Microprocessors
- Traffic control
- Weather balloons
- Medical systems
- Military applications
- Communication systems
- Agrarian applications
- Machine control
- Environmental applications.

QUICK REFERENCE

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT
f_{nom}	nominal frequency: fundamental mode	2.4	–	27.0	MHz
	third overtone	16.8	–	75.0	MHz
	fifth overtone	50.0	–	125.0	MHz
T_{oper}	operating temperature	–40	–	+105	°C
T_{op}	operable temperature	–55	–	+155	°C
$\Delta f/f_{\text{nom}}$	adjustment tolerance	±5	±10	–	ppm
$\Delta f/f_{25}$	frequency stability over temperature range: –20 to +70 °C with respect to $T_{\text{amb}} = 25 \text{ °C}$:				
	class 0	–	±10	–	ppm
	class 1	–	±15	–	ppm
	class 2	–	±20	–	ppm
C_1	motional capacitance tolerance	±5	±10	–	%
C_0	parallel capacitance tolerance	±5	±10	–	%
$\Delta f/f$	ageing over 10 years at 25 °C	±3	–	±5	ppm

DESCRIPTION

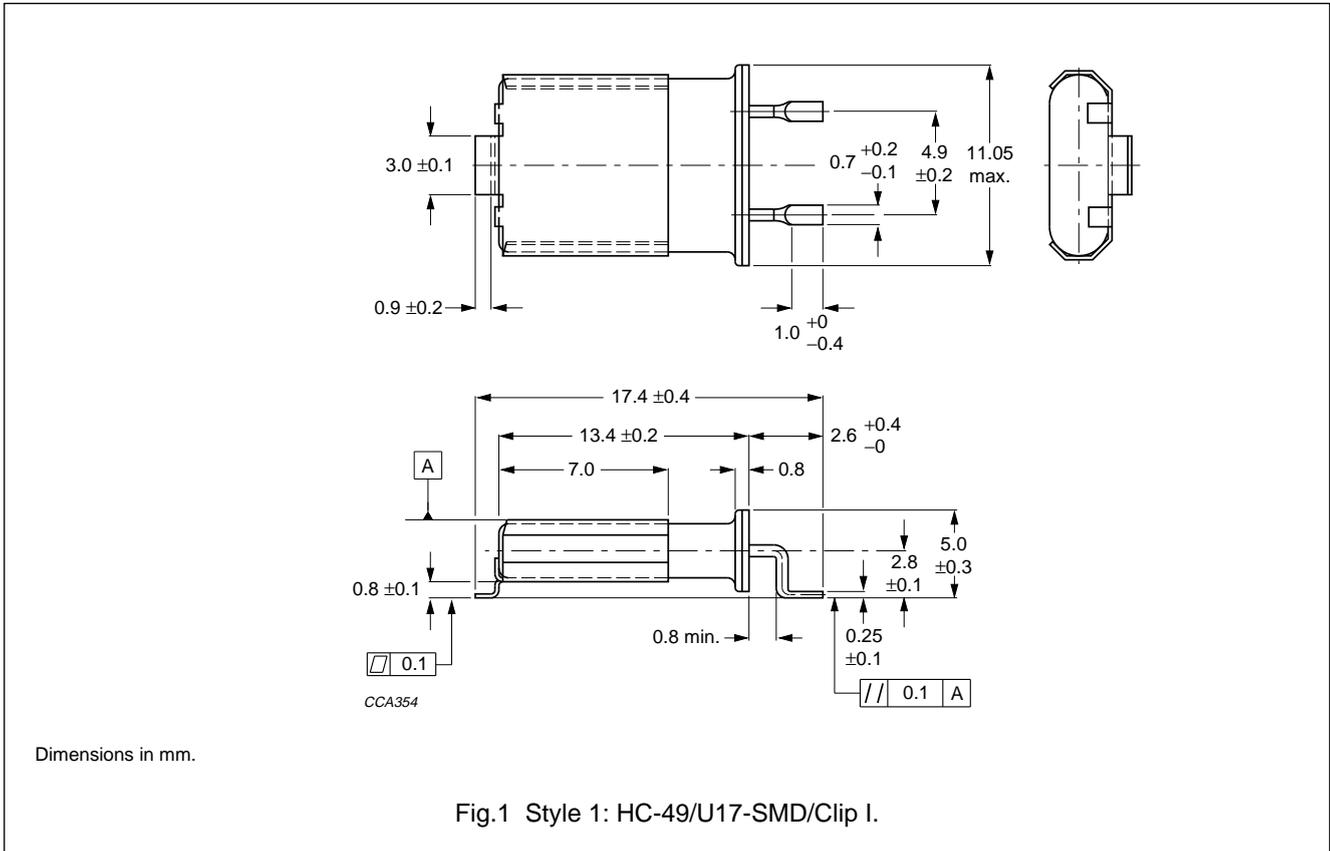
The unit consists of a silver-plated AT-cut quartz plate, encapsulated in a nitrogen-filled metal holder. The holder is hermetically sealed by resistance welding and provided with connections for surface mounting.

Quartz crystals - professional applications
 HC-49/SMD-like

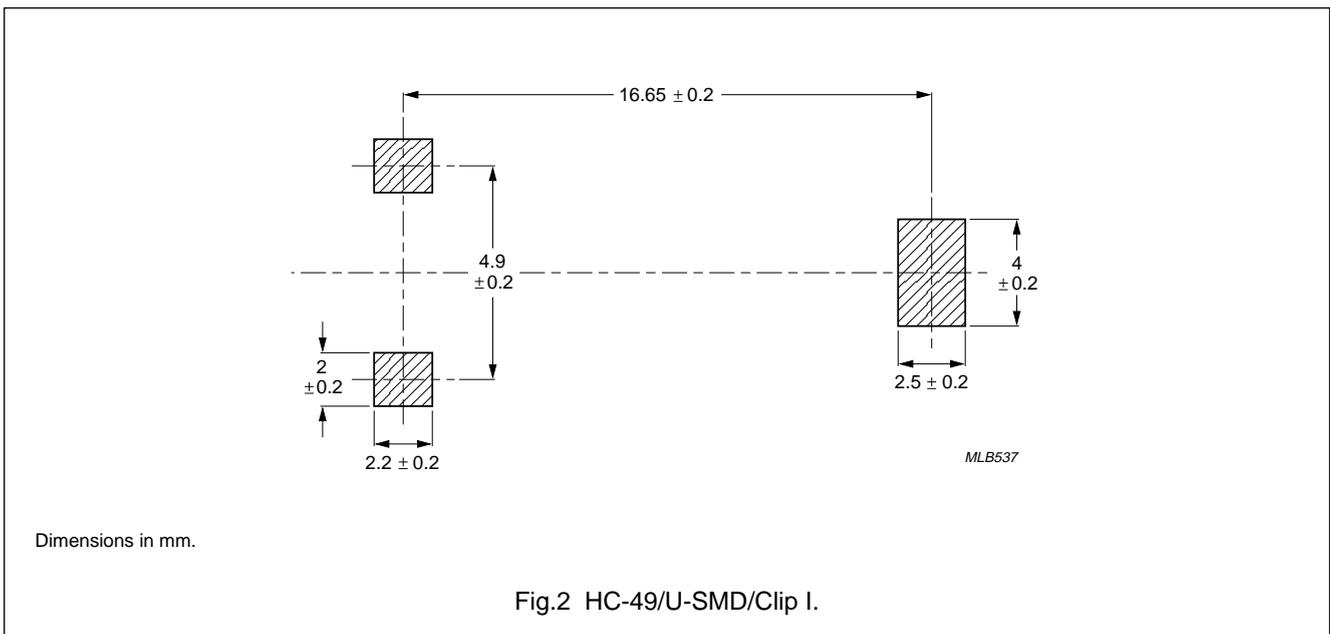
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MECHANICAL DATA

Package outlines



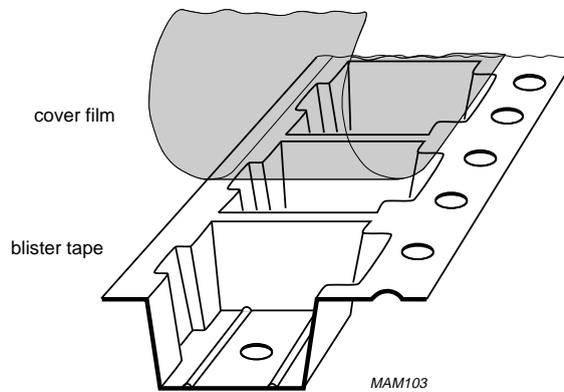
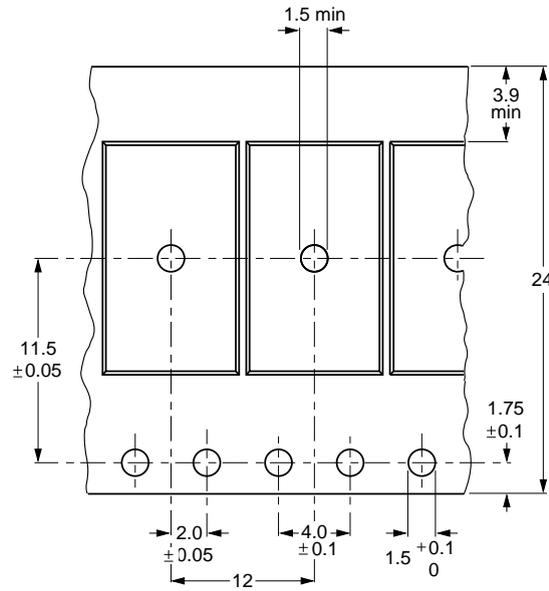
Recommended pad layout



Quartz crystals - professional applications
 HC-49/SMD-like

9922 522 43... series

Tape and reel data



Dimensions in mm.

Crystal connections are adjacent to sprocket holes.

Cumulative pitch error: ≤0.2 mm over 10 pitches.

Total tape height of tape with top film: 5.8 mm maximum.

Tape thickness: 0.3 mm.

The blister is made of conductive polystyrene. Taping is performed in accordance with "IEC 286-3".

Leader: minimum 400 mm including 100 mm sealed with empty compartments.

Trailer: minimum 160 mm sealed with empty compartments.

Pocket dimensions:

Length = 18.3 ± 0.1 mm

Width = 11.4 ± 0.1 mm

Depth = 5.6 +0.05/-0 mm.

Fig.3 Blister tape.

Quartz crystals - professional applications
 HC-49/SMD-like

9922 522 43... series

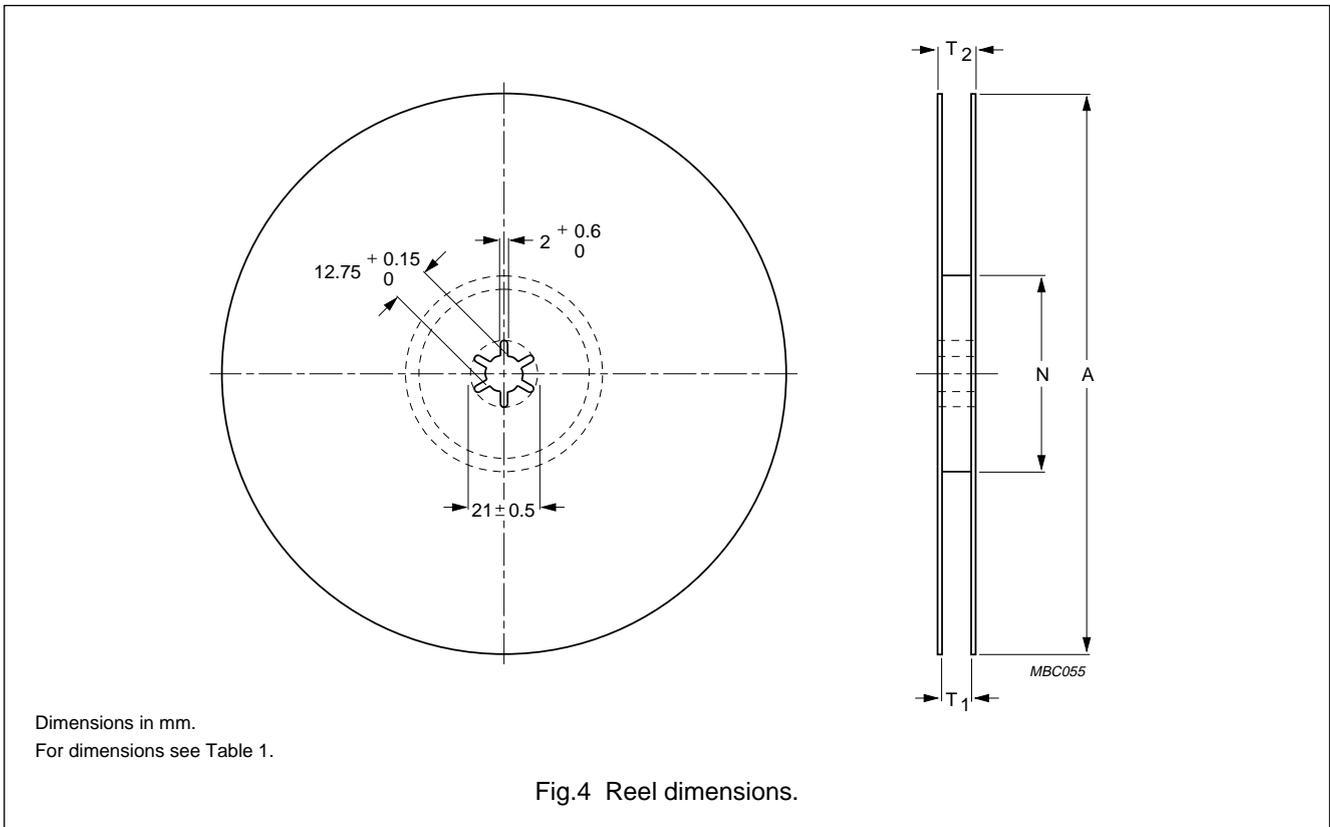


Table 1 Reel dimensions; see Fig.4

TAPE WIDTH (mm)	A (mm)	N (mm)	T ₁ (mm)	T ₂ (mm)
24	330	62 ± 1.5	24.4 +0.2/-0	28.4 ± 0.2

PACKAGING AND QUANTITIES

STYLE	PACKAGING	QUANTITY	DIMENSIONS OF BOX (mm)		
			LENGTH	WIDTH	HEIGHT
1	blister tape on reel	700 units per reel	338	338	38
	blister tray	700 units per box	200	125	70

STANDARD MARKING⁽¹⁾

- Line 1: PHILIPS
- Line 2: frequency in kHz (fundamental mode) or in MHz (overtone)
- Line 3: last five digits of catalogue number followed by the manufacturing date code (last three digits of week code).

MASS AND LEADS

Typical mass: 1.2 g.

The leads are finished with either Sn99Cu1 or Sn60Pb40 on a nickel underplate.

The first 1 mm from the body is not guaranteed for soldering.

(1) Special marking on product and/or package is available on request.

Quartz crystals - professional applications

HC-49/SMD-like

9922 522 43... series

ELECTRICAL DATA

Valid at $T_{amb} = 25 \pm 2 \text{ }^\circ\text{C}$ and a nominal drive level of $100 \text{ } \mu\text{W}$ into $25 \text{ } \Omega$ unless otherwise specified. Measuring system: π -network in accordance with "IEC 444" recommendations.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
f_{nom}	nominal frequency	fundamental	2.4	–	27.0	MHz
		third overtone	16.8	–	75.0	MHz
		fifth overtone	50.0	–	125.0	MHz
$\Delta f/f_{nom}$	adjustment tolerance		± 5	± 10	–	ppm
R_r	resonance resistance	see note 1	–	–	–	Ω
C_L	load capacitance	see note 2	5	20	∞	pF
T_{oper}	operating temperature		–40	–	+105	$^\circ\text{C}$
T_{op}	operable temperature		–55	–	+155	$^\circ\text{C}$
$\Delta f/f_{25}$	frequency stability over temperature range, with respect to $T_{amb} = 25 \text{ }^\circ\text{C}$		see Table 2			ppm
$R_r(T)$	resonance resistance over temperature range	see note 1	available from R_r upwards			Ω
C_1	motional capacitance					fF
	tolerance		± 5	± 10	–	%
C_0	parallel capacitance					pF
	tolerance		± 5	± 10	–	%
S	pulling sensitivity		$S = -0.5 C_1 / (C_0 + C_L)^2$			ppm/pF
R_n	resonance resistance of unwanted response (spurious)	fundamental mode; $f_{nom} \pm 20\%$	$2 R_r(T)$	–	–	Ω
			+6	–	–	dB
	overtones; $f_{nom} \pm 200 \text{ kHz}$	$2 R_r(T)$	–	–	Ω	
		+6	–	–	dB	
R_{dld}	drive level dependency, being the resonance resistance in the drive level range	drive level range 10^{-16} W to 10^{-4} W ; note 1	see note 2			Ω
R_{ins}	insulation resistance	DC test voltage = 100 V	500	–	–	$\text{M}\Omega$
$\Delta f/f_{nom}$	total frequency stability with respect to f_{nom}	including temperature range and ageing	see Table 2			ppm
	frequency hysteresis or discontinuity		–	–	1	ppm
$\Delta f/f$	ageing	see Figs 5 and 6	± 3	–	± 5	ppm

Notes

1. All resistance values are measured in series resonance. Load resonance measurement is available on request.
2. Values available on request.

Quartz crystals - professional applications
 HC-49/SMD-like

9922 522 43... series

Table 2 Frequency stability with temperature variation (available maximum values)

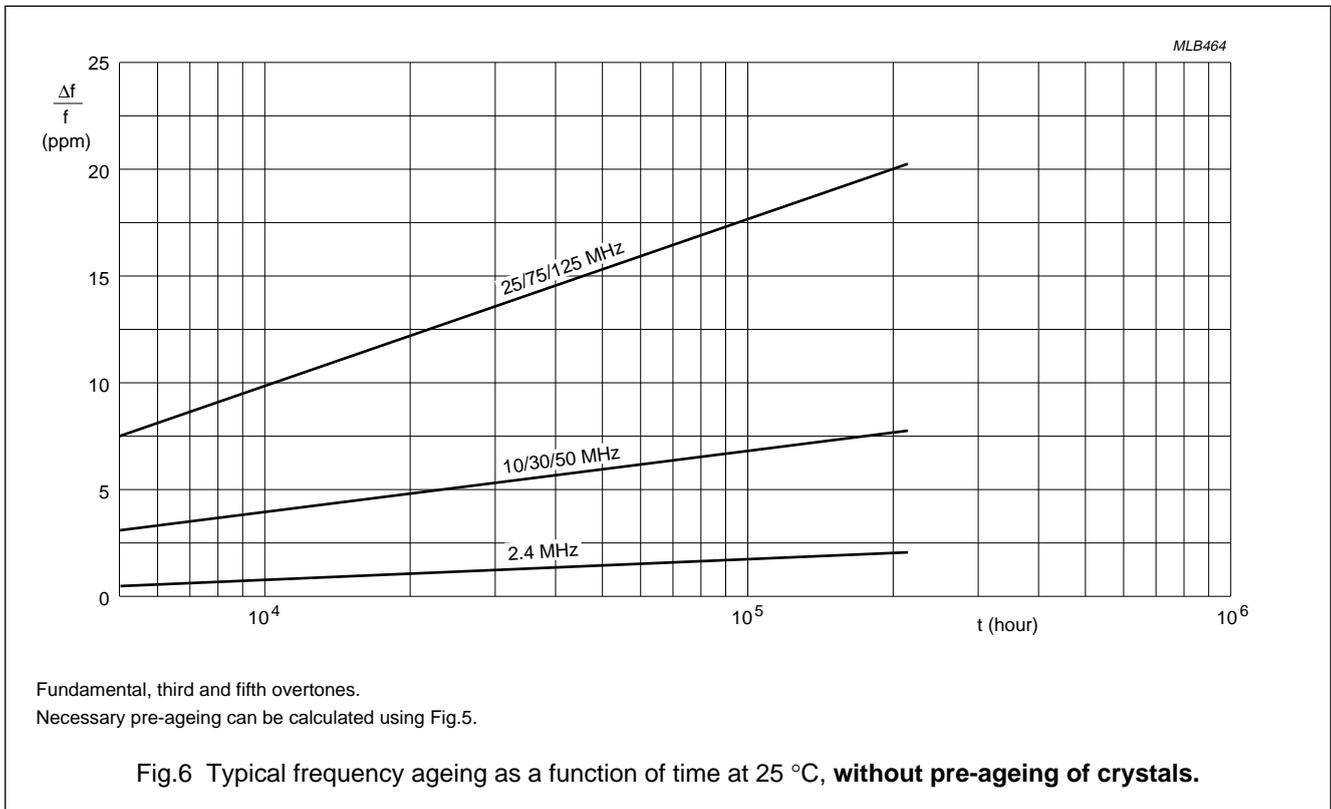
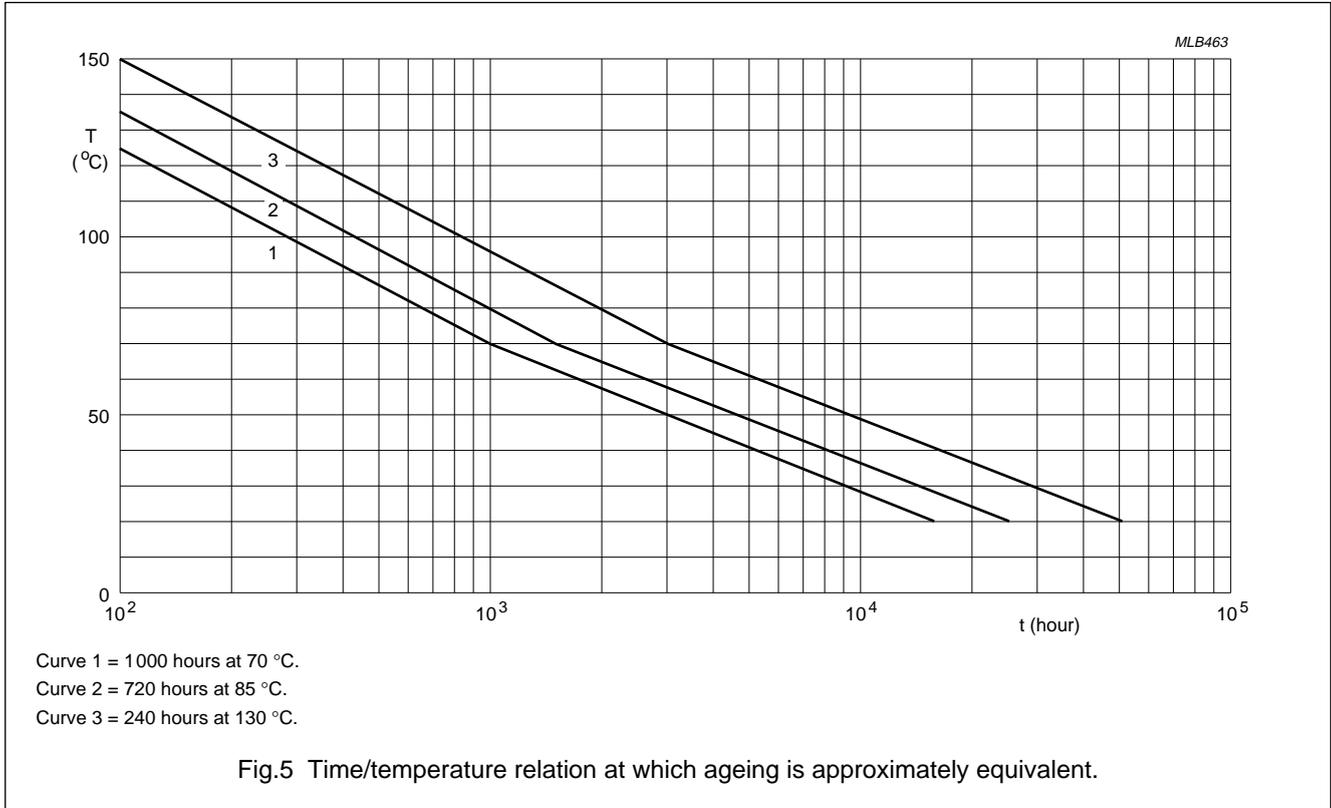
TEMPERATURE RANGE ⁽¹⁾ (°C)	FREQUENCY STABILITY (ppm)		
	CLASS 0	CLASS 1	CLASS 2
+20/+30	±1.0	±1.5	±2.0
0/+50	±5.0	±7.5	±10.0
-10/+60	±7.5	±10.0	±15.0
-20/+70	±10.0	±15.0	±20.0
-30/+80	±12.5	±20.0	±25.0
-40/+90	±17.5	±25.0	±30.0
-55/+105	±25.0	±30.0	±40.0
-40/+130	–	±50.0	±80.0

Note

1. To obtain the same stability at frequencies below 8.0 MHz, the upper temperature limit is 10 °C lower.

Quartz crystals - professional applications
 HC-49/SMD-like

9922 522 43... series



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HC-49/SMD-like

9922 522 43... series

TESTS AND REQUIREMENTS

Essentially all tests are carried out in accordance with IEC publication 68-2, "Recommended basic climatic and mechanical robustness testing procedure for electronic components" and IEC publication 1178-1, "Generic specification for quartz crystal units".

Table 3 Test procedures and requirements; note 1

IEC 68-2 METHOD	TEST	PROCEDURE	REQUIREMENTS
Ba	ageing	1 000 hours at 70 °C	$\Delta f/f \leq \pm 5$ ppm $\Delta R_r \pm 5 \Omega$ or $\pm 20\%$ whichever is the greater
Db	accelerated damp heat	+25 to +55 °C; 6 cycles at RH >95%	$\Delta f/f \leq \pm 5$ ppm $\Delta R_r \pm 5 \Omega$ or $\pm 20\%$ whichever is the greater
Ea	shock; note 2	100 g; half sinewave; 6 directions; 1 blow/direction	$\Delta f/f \leq \pm 5$ ppm $\Delta R_r \pm 5 \Omega$ or $\pm 20\%$ whichever is the greater
Eb	bump; note 2	4 000 bumps of 40 g	$\Delta f/f \leq \pm 5$ ppm $\Delta R_r \pm 5 \Omega$ or $\pm 20\%$ whichever is the greater
Ed	free fall; note 2	3 times on hard wood; for height of fall (h) see Table 4	$\Delta f/f \leq \pm 5$ ppm $\Delta R_r \pm 5 \Omega$ or $\pm 20\%$ whichever is the greater
Fc	vibration	frequency 10 to 500 to 10 Hz; acceleration 10 g; 3 directions; 30 minutes/direction	$\Delta f/f \leq \pm 5$ ppm $\Delta R_r \pm 5 \Omega$ or $\pm 20\%$ whichever is the greater
Na	temperature cycling test	-40 to +85 °C; 10 cycles; 0.1 hour/cycle	$\Delta f/f \leq \pm 5$ ppm $\Delta R_r \pm 5 \Omega$ or $\pm 20\%$ whichever is the greater
Q	sealing (method 1)	16 hours; 700 kPa He	$< 1 \times 10^{-8}$ ncc/s He
Ta	solderability	235 \pm 5 °C; 2 \pm 0.5 s; flux 600 (activated); optional steam pre-heat 8 hours. This reflects at least 36 months of storage at room conditions	$\geq 90\%$, on the flat lead part; no visible damage, no leaks
Tb	resistance to reflow soldering	rise 10 K/s; dwell 2 min/160 °C; rise 10 K/s up to 280 °C; cool down	$\Delta f/f \leq \pm 5$ ppm $\Delta R_r \pm 5 \Omega$ or $\pm 20\%$ whichever is the greater

Quartz crystals - professional applications HC-49/SMD-like

9922 522 43... series

IEC 68-2 METHOD	TEST	PROCEDURE	REQUIREMENTS
Other applicable tests			
Xa	resistance to solvents; note 3: Bio-Act EC7 [®] ; Neutropon P3 [®] and Saxin P3 [®] ; Meta Clean 820 [®] ; Lonco 446 [®] ; Isopropanol cleaning solvent; Dowanol DPM [®] (glass crystals only)	in accordance with "IEC 68-2-45", "IEC 653" (immersion time 5 minutes) and "MIL 202 E215". At ambient temperature and ultrasonic frequency (40 kHz)	no degradation of marking

Notes

1. Test table including MIL-specs ("MIL-Std 883" and "MIL-Std 202") can be provided upon request.
2. Mechanical tests to be performed on units clamped to a printed-circuit board for the total unit height.
3. Bio-Act is a registered trademark of Petroform.
Neutropon P3 and Saxin P3 are registered trademarks of Henkel.
Meta Clean 820 is a registered trademark of Mavom.
Lonco 447 is a registered trademark of London Chemical Co.
Dowanol DPM is a registered trademark of Dow Chemical.

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 HC-49/SMD-like

9922 522 43... series

Table 4 Height of fall

h (mm)	PRODUCT LENGTH (mm)	FREQUENCY RANGE ⁽¹⁾ (MHz)		
		FUNDAMENTAL MODE	THIRD OVERTONE	FIFTH OVERTONE
750	17	2.4 to 16.0	20.0 to 48.0	50.0 to 80.0
500	17	16.1 to 27.0	48.1 to 75.0	80.1 to 125.0

Note

- Standard values. Actual designs can be made to obtain higher or lower values.

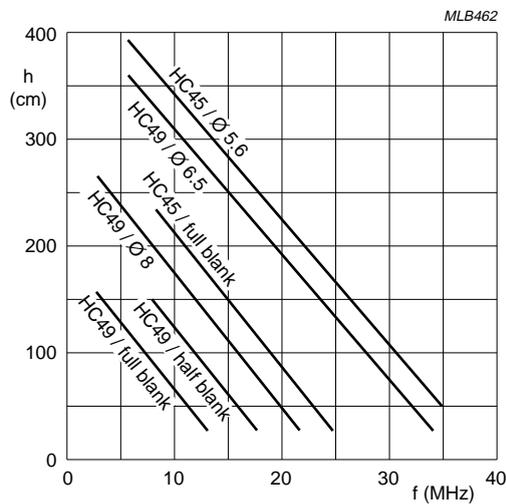


Fig.7 Typical height of fall values (3× on hard wood) for various quartz blank and holder combinations. 'Full' and 'half' blanks refer to rectangular quartz designs; 'Ø' designates circular quartz designs and the appropriate diameter.